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"[Embedded - Microcontrollers](#)" refer to small, integrated circuits designed to perform specific tasks within larger systems. These microcontrollers are essentially compact computers on a single chip, containing a processor core, memory, and programmable input/output peripherals. They are called "embedded" because they are embedded within electronic devices to control various functions, rather than serving as standalone computers. Microcontrollers are crucial in modern electronics, providing the intelligence and control needed for a wide range of applications.

Applications of "[Embedded - Microcontrollers](#)"

Details

Product Status	Active
Core Processor	Coldfire V2
Core Size	32-Bit Single-Core
Speed	60MHz
Connectivity	Ethernet, I ² C, SPI, UART/USART
Peripherals	DMA, LVD, POR, PWM, WDT
Number of I/O	73
Program Memory Size	128KB (128K x 8)
Program Memory Type	FLASH
EEPROM Size	-
RAM Size	32K x 8
Voltage - Supply (Vcc/Vdd)	3V ~ 3.6V
Data Converters	A/D 8x12b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 85°C (TA)
Mounting Type	Surface Mount
Package / Case	112-LQFP
Supplier Device Package	112-LQFP (20x20)
Purchase URL	https://www.e-xfl.com/pro/item?MUrl=&PartUrl=mcf52230cal60

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MCF52235 Family Configurations

- Based on and includes all existing features of the Freescale TouCAN module
- Full implementation of the CAN protocol specification version 2.0B
 - Standard Data and Remote Frames (up to 109 bits long)
 - Extended Data and Remote Frames (up to 127 bits long)
 - 0–8 bytes data length
 - Programmable bit rate up to 1 Mbit/sec
- Flexible Message Buffers (MBs), totalling up to 16 message buffers of 0–8 byte data length each, configurable as Rx or Tx, all supporting standard and extended messages
- Unused Message Buffer space can be used as general purpose RAM space
- Listen only mode capability
- Content-related addressing
- No read/write semaphores required
- Three programmable mask registers: global for MBs 0-13, special for MB14, and special for MB15
- Programmable transmit-first scheme: lowest ID or lowest buffer number
- Time stamp based on 16-bit free-running timer
- Global network time, synchronized by a specific message
- Maskable interrupts
- Three universal asynchronous/synchronous receiver transmitters (UARTs)
 - 16-bit divider for clock generation
 - Interrupt control logic with maskable interrupts
 - DMA support
 - Data formats can be 5, 6, 7 or 8 bits with even, odd or no parity
 - Up to 2 stop bits in 1/16 increments
 - Error-detection capabilities
 - Modem support includes request-to-send (RTS) and clear-to-send (CTS) lines for two UARTs
 - Transmit and receive FIFO buffers
- I²C module
 - Interchip bus interface for EEPROMs, LCD controllers, A/D converters, and keypads
 - Fully compatible with industry-standard I²C bus
 - Master and slave modes support multiple masters
 - Automatic interrupt generation with programmable level
- Queued serial peripheral interface (QSPI)
 - Full-duplex, three-wire synchronous transfers
 - Up to four chip selects available
 - Master mode operation only
 - Programmable bit rates up to half the CPU clock frequency
 - Up to 16 pre-programmed transfers
- Fast analog-to-digital converter (ADC)
 - Eight analog input channels
 - 12-bit resolution
 - Minimum 1.125 μ s conversion time
 - Simultaneous sampling of two channels for motor control applications
 - Single-scan or continuous operation
 - Optional interrupts on conversion complete, zero crossing (sign change), or under/over low/high limit
 - Unused analog channels can be used as digital I/O

1.2.15 Periodic Interrupt Timers (PIT0 and PIT1)

The two periodic interrupt timers (PIT0 and PIT1) are 16-bit timers that provide interrupts at regular intervals with minimal processor intervention. Each timer can count down from the value written in its PIT modulus register or can be a free-running down-counter.

1.2.16 Pulse Width Modulation (PWM) Timers

The MCF52235 has an 8-channel, 8-bit PWM timer. Each channel has a programmable period and duty cycle as well as a dedicated counter. Each of the modulators can create independent continuous waveforms with software-selectable duty rates from 0 to 100%. The PWM outputs have programmable polarity and can be programmed as left-aligned outputs or center-aligned outputs. For higher period and duty cycle resolution, each pair of adjacent channels ([7:6], [5:4], [3:2], and [1:0]) can be concatenated to form a single 16-bit channel. The module can, therefore, be configured to support 8/0, 6/1, 4/2, 2/3, or 0/4 8-/16-bit channels.

1.2.17 Software Watchdog Timer

The watchdog timer is a 32-bit timer that facilitates recovery from runaway code. The watchdog counter is a free-running down-counter that generates a reset on underflow. To prevent a reset, software must periodically restart the countdown.

1.2.18 Phase Locked Loop (PLL)

The clock module contains a crystal oscillator, 8 MHz on-chip relaxation oscillator (OCO), phase-locked loop (PLL), reduced frequency divider (RFD), low-power divider status/control registers, and control logic. To improve noise immunity, the PLL, crystal oscillator, and relaxation oscillator have their own power supply inputs: VDDPLL and VSSPLL. All other circuits are powered by the normal supply pins, VDD and VSS.

1.2.19 Interrupt Controller (INTC0/INTC1)

There are two interrupt controllers on the MCF52235. These interrupt controllers are organized as seven levels with up to nine interrupt sources per level. Each interrupt source has a unique interrupt vector, and provide each peripheral with all necessary interrupts. Each internal interrupt has a programmable level [1-7] and priority within the level. The seven external interrupts have fixed levels/priorities.

1.2.20 DMA Controller

The direct memory access (DMA) controller provides an efficient way to move blocks of data with minimal processor intervention. It has four channels that allow byte, word, longword, or 16-byte burst line transfers. These transfers are triggered by software explicitly setting a DCRn[START] bit or by the occurrence of certain UART or DMA timer events.

1.2.21 Reset

The reset controller determines the source of reset, asserts the appropriate reset signals to the system, and keeps track of what caused the last reset. There are seven sources of reset:

- External reset input
- Power-on reset (POR)
- Watchdog timer
- Phase locked-loop (PLL) loss of lock
- PLL loss of clock
- Software

1.2.24 Package Pinouts

Figure 2 shows the pinout configuration for the 80-pin LQFP.

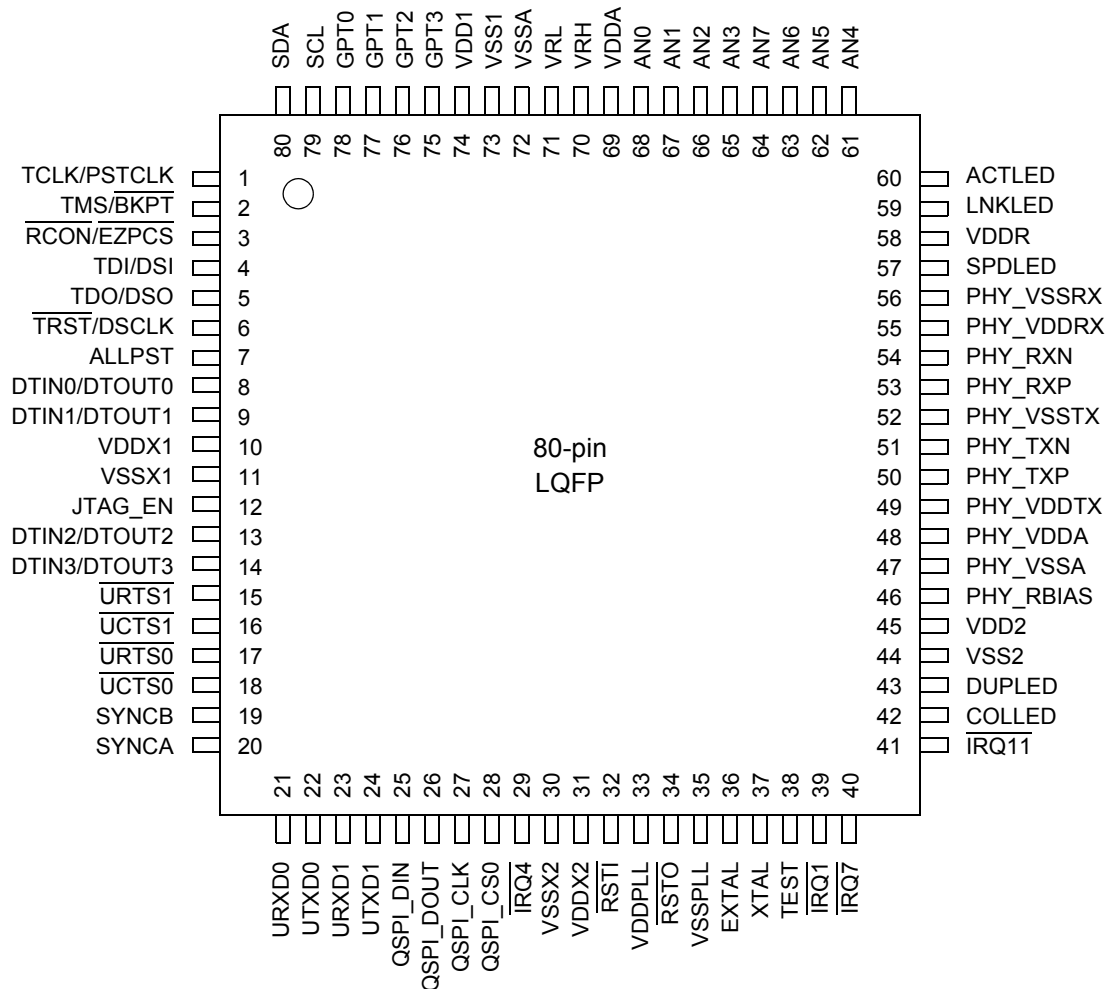


Figure 2. 80-pin LQFP Pin Assignments

Figure 3 shows the pinout configuration for the 112-pin LQFP.

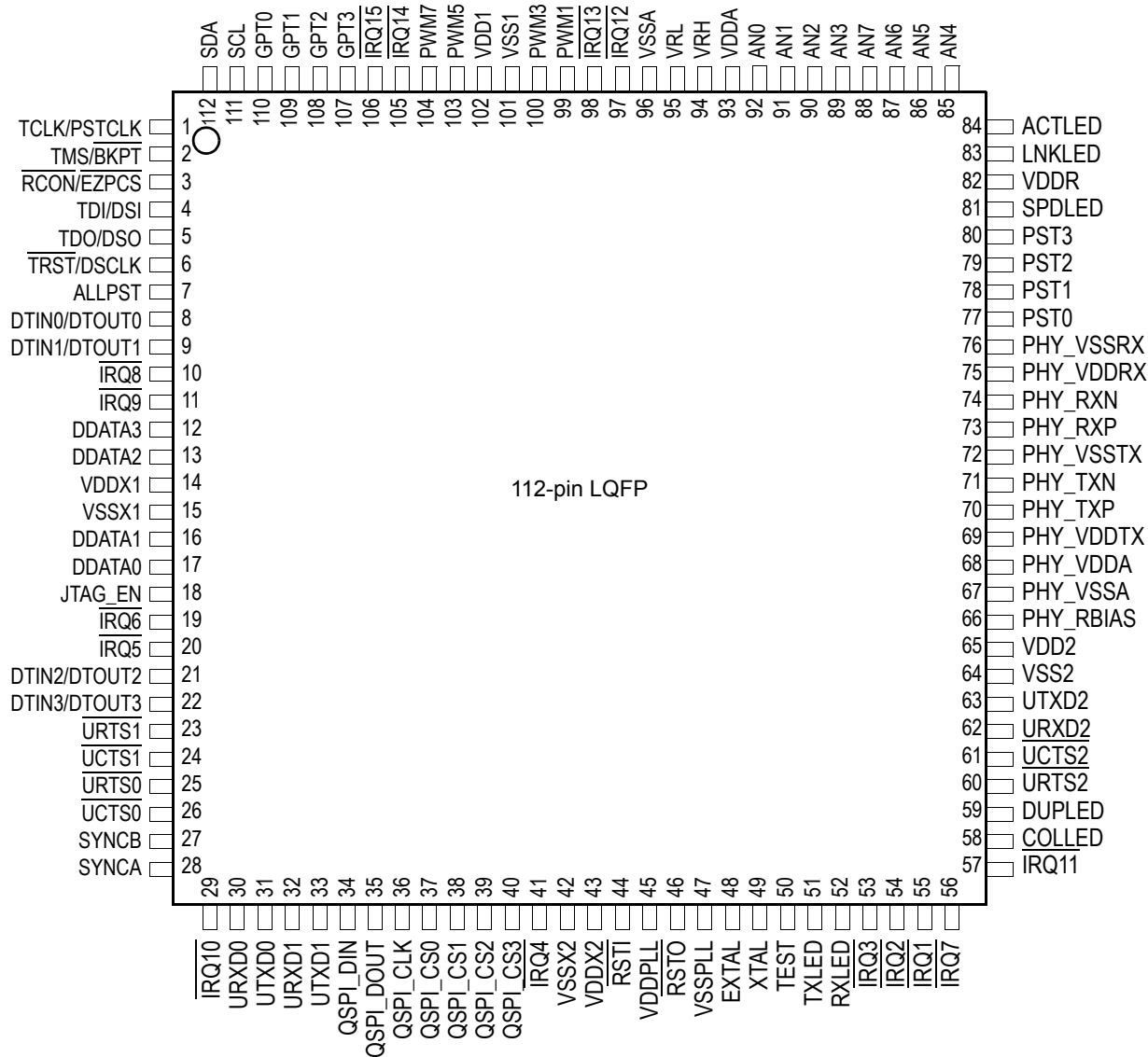


Figure 3. 112-pin LQFP Pin Assignments

Figure 4 shows the pinout configuration for the 121 MAPBGA.

	1	2	3	4	5	6	7	8	9	10	11
A	TCLK	SDA	SCL	$\overline{\text{IRQ15}}$	$\overline{\text{IRQ14}}$	$\overline{\text{IRQ13}}$	VSSA	VDDA	AN1	AN7	AN5
B	TMS	$\overline{\text{RCON}}$	GPT0	GPT3	PWM5	PWM1	VRL	VRH	AN2	AN6	AN4
C	$\overline{\text{TRST}}$	TDO	TDI	GPT2	PWM7	PWM3	$\overline{\text{IRQ12}}$	AN0	AN3	LNKLED	ACTLED
D	DTIN1	DTIN0	ALLPST	GPT1	VDDX	VDDX	VDD	VDDR	PST2	PST3	SPDLED
E	DDATA3	$\overline{\text{IRQ9}}$	$\overline{\text{IRQ8}}$	VSS	VSS	VDDX	VSS	VDD	PST0	PST1	PHY_RXN
F	DDATA0	DDATA1	DDATA2	VSS	VSS	VSS	VSS	VSS	PHY_VSSRX	PHY_VDDR	PHY_RXP
G	DTIN2	$\overline{\text{IRQ5}}$	$\overline{\text{IRQ6}}$	JTAG_EN	VDDX	VDDX	VDDX	PHY_VSSA	PHY_VSSTX	PHY_VDDTX	PHY_TXP
H	DTIN3	$\overline{\text{URTS0}}$	$\overline{\text{URTS1}}$	QSPI_DIN	QSPI_CS1	VDDX	TEST	TXLED	RXLED	PHY_VDDA	PHY_TXN
J	SYNCB	$\overline{\text{UCTS0}}$	$\overline{\text{UCTS1}}$	QSPI_DOUT	QSPI_CS2	$\overline{\text{RSTI}}$	XTAL	$\overline{\text{IRQ1}}$	COLLED	DUPLED	PHY_RBIAS
K	SYNCA	URXD0	URXD1	QSPI_CLK	QSPI_CS3	VDDPLL	VSSPLL	$\overline{\text{IRQ2}}$	$\overline{\text{IRQ11}}$	$\overline{\text{URTS2}}$	URXD2
L	$\overline{\text{IRQ10}}$	UTXD0	UTXD1	QSPI_CS0	$\overline{\text{IRQ4}}$	$\overline{\text{RSTO}}$	EXTAL	$\overline{\text{IRQ3}}$	$\overline{\text{IRQ7}}$	$\overline{\text{UCTS2}}$	UTXD2

Figure 4. 121 MAPBGA Pin Assignments

Table 3. Pin Functions by Primary and Alternate Purpose

Pin Group	Primary Function	Secondary Function	Tertiary Function	Quaternary Function	Drive Strength/Control ¹	Wired OR Control	Pull-up/Pull-down ²	Pin on 121 MAPBGA	Pin on 112 LQFP	Pin on 80 LQFP
ADC ³	AN7	—	—	PAN[7]	Low	—	—	A10	88	64
	AN6	—	—	PAN[6]	Low	—	—	B10	87	63
	AN5	—	—	PAN[5]	Low	—	—	A11	86	62
	AN4	—	—	PAN[4]	Low	—	—	B11	85	61
	AN3	—	—	PAN[3]	Low	—	—	C9	89	65
	AN2	—	—	PAN[2]	Low	—	—	B9	90	66
	AN1	—	—	PAN[1]	Low	—	—	A9	91	67
	AN0	—	—	PAN[0]	Low	—	—	C8	92	68
	SYNCA	CANTX ⁴	FEC_MDIO	PAS[3]	PDSR[39]	—	—	K1	28	20
	SYNCB	CANRX ⁴	FEC_MDC	PAS[2]	PDSR[39]	—	—	J1	27	19
	VDDA	—	—	—	N/A	N/A	—	A8	93	69
	VSSA	—	—	—	N/A	N/A	—	A7	96	72
	VRH	—	—	—	N/A	N/A	—	B8	94	70
	VRL	—	—	—	N/A	N/A	—	B7	95	71
	EXTAL	—	—	—	N/A	N/A	—	L7	48	36
Clock Generation	XTAL	—	—	—	N/A	N/A	—	J7	49	37
	VDDPLL ⁵	—	—	—	N/A	N/A	—	K6	45	33
	VSSPLL	—	—	—	N/A	N/A	—	K7	47	35
	ALLPST	—	—	—	High	—	—	D3	7	7
Debug Data	DDATA[3:0]	—	—	PDD[7:4]	High	—	—	E1, F3,F2, F1	12,13,16,17	—
	PST[3:0]	—	—	PDD[3:0]	High	—	—	D10, D9, E10, E9	80,79,78,77	—

Table 3. Pin Functions by Primary and Alternate Purpose (continued)

Pin Group	Primary Function	Secondary Function	Tertiary Function	Quaternary Function	Drive Strength/Control ¹	Wired OR Control	Pull-up/Pull-down ²	Pin on 121 MAPBGA	Pin on 112 LQFP	Pin on 80 LQFP
QSPI ³	QSPI_DIN/EZPD	CANRX ⁴	URXD1	PQS[1]	PDSR[2]	PWOR[4]	—	H4	34	25
	QSPI_DOUT/EZPQ	CANTX ⁴	UTXD1	PQS[0]	PDSR[1]	PWOR[5]	—	J4	35	26
	QSPI_CLK/EZPCK	SCL	URTS1	PQS[2]	PDSR[3]	PWOR[6]	Pull-Up ⁸	K4	36	27
	QSPI_CS3	SYNCA	SYNCB	PQS[6]	PDSR[7]	—	—	K5	40	—
	QSPI_CS2	—	FEC_TXCLK	PQS[5]	PDSR[6]	—	—	J5	39	—
	QSPI_CS1	—	FEC_TXEN	PQS[4]	PDSR[5]	—	—	H5	38	—
	QSPI_CS0	SDA	UCTS1	PQS[3]	PDSR[4]	PWOR[7]	Pull-Up ⁸	L4	37	28
Reset ⁹	RSTI	—	—	—	N/A	N/A	Pull-Up ⁹	J6	44	32
	RSTO	—	—	—	high	—	—	L6	46	34
Test	TEST	—	—	—	N/A	N/A	Pull-Down	H7	50	38
Timers, 16-bit ³	GPT3	FEC_TXD[3]	PWM7	PTA[3]	PDSR[23]	—	Pull-Up ¹⁰	B4	107	75
	GPT2	FEC_TXD[2]	PWM5	PTA[2]	PDSR[22]	—	Pull-Up ¹⁰	C4	108	76
	GPT1	FEC_TXD[1]	PWM3	PTA[1]	PDSR[21]	—	Pull-Up ¹⁰	D4	109	77
	GPT0	FEC_TXER	PWM1	PTA[0]	PDSR[20]	—	Pull-Up ¹⁰	B3	110	78
Timers, 32-bit	DTIN3	DTOUT3	PWM6	PTC[3]	PDSR[19]	—	—	H1	22	14
	DTIN2	DTOUT2	PWM4	PTC[2]	PDSR[18]	—	—	G1	21	13
	DTIN1	DTOUT1	PWM2	PTC[1]	PDSR[17]	—	—	D1	9	9
	DTIN0	DTOUT0	PWM0	PTC[0]	PDSR[16]	—	—	D2	8	8
UART 0 ³	$\overline{UCTS0}$	CANRX ⁴	FEC_RXCLK	PUA[3]	PDSR[11]	—	—	J2	26	18
	$\overline{URTS0}$	CANTX ⁴	FEC_RXDV	PUA[2]	PDSR[10]	—	—	H2	25	17
	URXD0	—	FEC_RXD[0]	PUA[1]	PDSR[9]	PWOR[0]	—	K2	30	21
	UTXD0	—	FEC_CRX	PUA[0]	PDSR[8]	PWOR[1]	—	L2	31	22

Table 3. Pin Functions by Primary and Alternate Purpose (continued)

Pin Group	Primary Function	Secondary Function	Tertiary Function	Quaternary Function	Drive Strength/Control ¹	Wired OR Control	Pull-up/Pull-down ²	Pin on 121 MAPBGA	Pin on 112 LQFP	Pin on 80 LQFP
UART 1 ³	UCTS1	SYNCA	URXD2	PUB[3]	PDSR[15]	—	—	J3	24	16
	URTS1	SYNCB	UTXD2	PUB[2]	PDSR[14]	—	—	H3	23	15
	URXD1	—	FEC_TXD[0]	PUB[1]	PDSR[13]	PWOR[2]	—	K3	32	23
	UTXD1	—	FEC_COL	PUB[0]	PDSR[12]	PWOR[3]	—	L3	33	24
UART 2	UCTS2	—	—	PUC[3]	PDSR[27]	—	—	L10	61	—
	URTS2	—	—	PUC[2]	PDSR[26]	—	—	K10	60	—
	URXD2	—	—	PUC[1]	PDSR[25]	—	—	K11	62	—
	UTXD2	—	—	PUC[0]	PDSR[24]	—	—	L11	63	—
FlexCAN	SYNCA	CANTX ⁴	FEC_MDIO	PAS[3]	PDSR[39]	—	—	—	28	20
	SYNCB	CANRX ⁴	FEC_MDC	PAS[2]	PDSR[39]	—	—	—	27	19
VDD ^{5,11}	VDD	—	—	—	N/A	N/A	—	D7, E8	65,102	45,74
VDDX	VDDX	—	—	—	N/A	N/A	—	D5, D6, E6, G5, G6, G7, H6	14, 43	10, 31
VSS	VSS	—	—	—	N/A	N/A	—	E4, E5, E7, F4, F5, F6, F7, F8	64,101	44,73
VSSX	VSSX	—	—	—	N/A	N/A	—	—	15, 42	11, 30

¹ The PDSR and PSSR registers are described in [Chapter 14, “General Purpose I/O Module](#). All programmable signals default to 2mA drive in normal (single-chip) mode.

² All signals have a pull-up in GPIO mode.

³ The use of an external PHY limits ADC, interrupt, and QSPI functionality. It also disables the UART0/1 and timer pins.

⁴ The multiplexed CANTX and CANRX signals do not have dedicated pins, but are available as muxed replacements for other signals.

⁵ The VDD1, VDD2, VDDPLL, and PHY_VDD pins are for decoupling only and should not have power directly applied to them.

⁶ For primary and GPIO functions only.

⁷ Only when JTAG mode is enabled.

⁸ For secondary and GPIO functions only.

⁹ RSTI has an internal pull-up resistor; however, the use of an external resistor is strongly recommended.

¹⁰ For GPIO function. Primary Function has pull-up control within the GPT module.

¹¹ This list for power and ground does not include those dedicated power/ground pins included elsewhere, e.g. in the Ethernet PHY.

1.12 ADC Signals

Table 13 describes the signals of the Analog-to-Digital Converter.

Table 13. ADC Signals

Signal Name	Abbreviation	Function	I/O
Analog Inputs	AN[7:0]	Inputs to the A-to-D converter.	I
Analog Reference	V _{RH}	Reference voltage high and low inputs.	I
	V _{RL}		I
Analog Supply	V _{DDA}	Isolate the ADC circuitry from power supply noise	—
	V _{SSA}		—

1.13 General Purpose Timer Signals

Table 14 describes the General Purpose Timer Signals.

Table 14. GPT Signals

Signal Name	Abbreviation	Function	I/O
General Purpose Timer Input/Output	GPT[3:0]	Inputs to or outputs from the general purpose timer module	I/O

1.14 Pulse Width Modulator Signals

Table 15 describes the PWM signals.

Table 15. PWM Signals

Signal Name	Abbreviation	Function	I/O
PWM Output Channels	PWM[7:0]	Pulse width modulated output for PWM channels	O

1.15 Debug Support Signals

These signals are used as the interface to the on-chip JTAG controller and also to interface to the BDM logic.

Table 16. Debug Support Signals

Signal Name	Abbreviation	Function	I/O
JTAG Enable	JTAG_EN	Select between debug module and JTAG signals at reset	I
Test Reset	$\overline{\text{TRST}}$	This active-low signal is used to initialize the JTAG logic asynchronously.	I
Test Clock	TCLK	Used to synchronize the JTAG logic.	I
Test Mode Select	TMS	Used to sequence the JTAG state machine. TMS is sampled on the rising edge of TCLK.	I
Test Data Input	TDI	Serial input for test instructions and data. TDI is sampled on the rising edge of TCLK.	I

The average chip-junction temperature (T_J) in °C can be obtained from

$$T_J = T_A + (P_D \times \Theta_{JMA}) \quad \text{Eqn. 1}$$

where

- T_A = ambient temperature, °C
- Θ_{JMA} = package thermal resistance, junction-to-ambient, °C/W
- $P_D = P_{INT} + P_{I/O}$
- P_{INT} = chip internal power, $I_{DD} \times V_{DD}$, watts
- $P_{I/O}$ = power dissipation on input and output pins — user determined

For most applications, $P_{I/O} < P_{INT}$ and can be ignored. An approximate relationship between P_D and T_J (if $P_{I/O}$ is neglected) is:

$$P_D = K \div (T_J + 273^\circ\text{C}) \quad \text{Eqn. 2}$$

Solving equations 1 and 2 for K gives:

$$K = P_D \times (T_A + 273^\circ\text{C}) + \Theta_{JMA} \times P_D^2 \quad \text{Eqn. 3}$$

where K is a constant pertaining to the particular part. K can be determined from Equation 3 by measuring P_D (at equilibrium) for a known T_A . Using this value of K, the values of P_D and T_J can be obtained by solving Equation 1 and Equation 2 iteratively for any value of T_A .

2.2 ESD Protection

Table 21. ESD Protection Characteristics¹

Characteristic	Symbol	Value	Units
ESD target for Human Body Model	HBM	1500 (ADC and EPHY pins) 2000 (All other pins)	V
ESD target for Charged Device Model	CDM	250	V
HBM circuit description	R_{series}	1500	ohms
	C	100	pF
Number of pulses per pin (HBM)			
positive pulses	—	1	—
negative pulses	—	1	—
Number of pulses per pin (CDM)			
positive pulses	—	3	—
negative pulses	—	3	—
Interval of pulses (HBM)	—	1.0	sec
Interval of pulses (CDM)	—	0.2	sec

¹ A device is defined as a failure if the device no longer meets the device specification requirements after exposure to ESD pulses. Complete DC parametric and functional testing is performed per applicable device specification at room temperature followed by hot temperature, unless specified otherwise in the device specification.

2.4 Phase Lock Loop Electrical Specifications

Table 25. Oscillator and PLL Electrical Specifications
 $(V_{DD} \text{ and } V_{DDPLL} = 2.7 \text{ to } 3.6 \text{ V}, V_{SS} = V_{SSPLL} = 0 \text{ V})$

Characteristic	Symbol	Min	Max	Unit
Clock Source Frequency Range of EXTAL Frequency Range • Crystal • External ¹	$f_{crystal}$ f_{ext}	0.5 0	25.0 60.0	MHz
PLL reference frequency range	f_{ref_pll}	2	10.0	MHz
System frequency ² External clock mode On-Chip PLL Frequency	f_{sys}	0 $f_{ref} / 32$	60 60	MHz
Loss of reference frequency ^{3, 5}	f_{LOR}	100	1000	kHz
Self clocked mode frequency ^{4, 5}	f_{SCM}	1	5	MHz
Crystal start-up time ^{5, 6}	t_{cst}	—	10	ms
EXTAL input high voltage Crystal reference External reference	V_{IHEXT}	$V_{DD} - 1.0$ 2.0	V_{DD} 3.0 ⁷	V
EXTAL input low voltage Crystal reference External reference	V_{ILEXT}	V_{SS} V_{SS}	1.0 0.8	V
XTAL output high voltage $I_{OH} = 1.0 \text{ mA}$	V_{OL}	$V_{DD} - 1.0$	—	V
XTAL output low voltage $I_{OL} = 1.0 \text{ mA}$	V_{OL}	—	0.5	V
XTAL load capacitance ⁸		—	—	pF
PLL lock time ^{5,9}	t_{ipll}	—	500	μs
Power-up to lock time ^{5, 7,9} With crystal reference Without crystal reference	t_{iplk}	— —	10.5 500	ms μs
Duty cycle of reference ⁵	t_{dc}	40	60	% f_{sys}
Frequency un-LOCK range	f_{UL}	-1.5	1.5	% f_{sys}
Frequency LOCK range	f_{LCK}	-0.75	0.75	% f_{sys}
CLKOUT period Jitter ^{5, 6, 8, 10,11} , measured at f_{sys} Max Peak-to-peak jitter (clock edge to clock edge) Long term jitter (averaged over 2 ms interval)	C_{jitter}	— —	10 0.01	% f_{sys}

¹ In external clock mode, it is possible to run the chip directly from an external clock source without enabling the PLL.

² All internal registers retain data at 0 Hz.

³ Loss of reference frequency is the reference frequency detected internally that transitions the PLL into self-clocked mode.

⁴ Self-clocked mode frequency is the frequency that the PLL operates at when the reference frequency falls below f_{LOR} with default MFD/RFD settings.

⁵ This parameter is characterized before qualification rather than 100% tested.

⁶ Proper PC board layout procedures must be followed to achieve specifications.

- ⁷ This value has been updated
- ⁸ Load capacitance determined from crystal manufacturer specifications and include circuit board parasitics.
- ⁹ Assuming a reference is available at power up, lock time is measured from the time V_{DD} and V_{DDPLL} are valid to $\overline{RSTO}$ negating. If the crystal oscillator is the reference for the PLL, the crystal start up time must be added to the PLL lock time to determine the total start-up time.
- ¹⁰ Jitter is the average deviation from the programmed frequency measured over the specified interval at maximum f_{sys} . Measurements are made with the device powered by filtered supplies and clocked by a stable external clock signal. Noise injected into the PLL circuitry via V_{DDPLL} and V_{SSPLL} and variation in crystal oscillator frequency increase the C_{jitter} percentage for a given interval
- ¹¹ Based on slow system clock of 40 MHz measured at f_{sys} max.

2.5 General Purpose I/O Timing

GPIO can be configured for certain pins of the QSPI, timers, UARTs, FEC, and interrupts. When in GPIO mode, the timing specification for these pins is given in [Table 26](#) and [Figure 6](#).

The GPIO timing is met under the following load test conditions:

- 50 pF / 50 Ω for high drive
- 25 pF / 25 Ω for low drive

Table 26. GPIO Timing

Num	Characteristic	Symbol	Min	Max	Unit
G1	CLKOUT high to GPIO output valid	t_{CHPOV}	—	10	ns
G2	CLKOUT high to GPIO output invalid	t_{CHPOI}	1.5	—	ns
G3	GPIO input valid to CLKOUT high	t_{PVCH}	9	—	ns
G4	CLKOUT high to GPIO input invalid	t_{CHPI}	1.5	—	ns

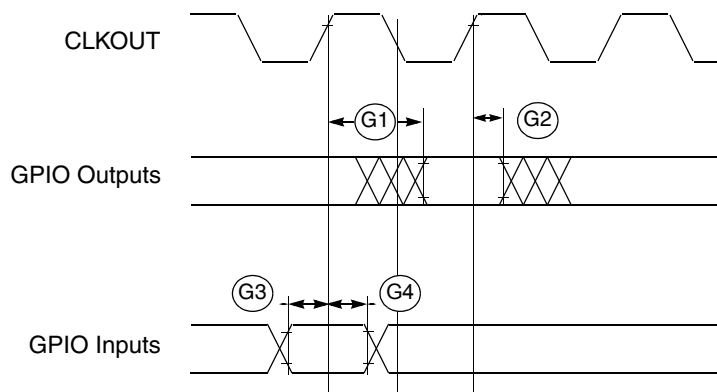


Figure 6. GPIO Timing

2.8.4 Transceiver Characteristics

Table 33. 10BASE-T Transceiver Characteristics

Parameter	Symbol	Min	Typ	Max	Units	Test Conditions
Peak differential output voltage	V_{OP}	2.2	2.5	2.8	V	With specified transformer and line replaced by $100\ \Omega (\pm 1\%)$ load
Transmit timing jitter	—	0	2	11	ns	Using line model specified in the IEEE 802.3
Receive dc input impedance	Z_{in}	—	10	—	$k\Omega$	$0.0 < V_{in} < 3.3\ V$
Receive differential squelch level	$V_{squelch}$	300	400	585	mV	3.3 MHz sine wave input

Table 34. 100BASE-TX Transceiver Characteristics

Parameter	Symbol	Min	Typ	Max	Units	Test Conditions
Transmit Peak Differential Output Voltage	V_{OP}	0.95	1.00	1.05	V	With specified transformer and line replaced by $100\ \Omega (\pm 1\%)$ load
Transmit Signal Amplitude Symmetry	V_{sym}	98	100	102	%	With specified transformer and line replaced by $100\ \Omega (\pm 1\%)$ load
Transmit Rise/Fall Time	t_{rf}	3	4	5	ns	With specified transformer and line replaced by $100\ \Omega (\pm 1\%)$ load
Transmit Rise/Fall Time Symmetry	t_{rfs}	−0.5	0	+0.5	ns	See IEEE 802.3 for details
Transmit Overshoot/UnderShoot	V_{osh}	—	2.5	5	%	
Transmit Jitter	—	0	.6	1.4	ns	
Receive Common Mode Voltage	V_{cm}	—	1.6	—	V	$V_{DDRX} = 2.5\ V$
Receiver Maximum Input Voltage	V_{max}	—	—	4.7	V	$V_{DDRX} = 2.5\ V$. Internal circuits protected by divider in shutdown

2.9 Analog-to-Digital Converter (ADC) Parameters

Table 35 lists specifications for the analog-to-digital converter.

Table 35. ADC Parameters¹

Name	Characteristic	Min	Typical	Max	Unit
V_{REFL}	Low reference voltage	V_{SS}	—	V_{REFH}	V
V_{REFH}	High reference voltage	V_{REFL}	—	V_{DDA}	V
V_{DDA}	Analog supply voltage	3.0	3.3	3.6	V
V_{ADIN}	Input voltages	V_{REFL}	—	V_{REFH}	V
RES	Resolution	12	—	12	bits
INL	Integral non-linearity (full input signal range) ²	—	± 2.5	± 3	LSB ³
INL	Integral non-linearity (10% to 90% input signal range) ⁴	—	± 2.5	± 3	LSB
DNL	Differential non-linearity	—	$-1 < DNL < +1$	$< +1$	LSB
	Monotonicity	Guaranteed			

2.13 JTAG and Boundary Scan Timing

Table 39. JTAG and Boundary Scan Timing

Num	Characteristics ¹	Symbol	Min	Max	Unit
J1	TCLK frequency of operation	f_{JCYC}	DC	1/4	$f_{sys}/2$
J2	TCLK cycle period	t_{JCYC}	$4 \times t_{CYC}$	—	ns
J3	TCLK clock pulse width	t_{JCW}	26	—	ns
J4	TCLK rise and fall times	t_{JCRF}	0	3	ns
J5	Boundary scan input data setup time to TCLK rise	t_{BSDST}	4	—	ns
J6	Boundary scan input data hold time after TCLK rise	t_{BSDHT}	26	—	ns
J7	TCLK low to boundary scan output data valid	t_{BSDV}	0	33	ns
J8	TCLK low to boundary scan output high Z	t_{BSDZ}	0	33	ns
J9	TMS, TDI input data setup time to TCLK rise	t_{TAPBST}	4	—	ns
J10	TMS, TDI input data hold time after TCLK rise	t_{TAPBHT}	10	—	ns
J11	TCLK low to TDO data valid	t_{TDODV}	0	26	ns
J12	TCLK low to TDO high Z	t_{TDODZ}	0	8	ns
J13	$\overline{TRST}$ assert time	t_{TRSTAT}	100	—	ns
J14	$\overline{TRST}$ setup time (negation) to TCLK high	t_{TRSTST}	10	—	ns

¹ JTAG_EN is expected to be a static signal. Hence, it is not associated with any timing.

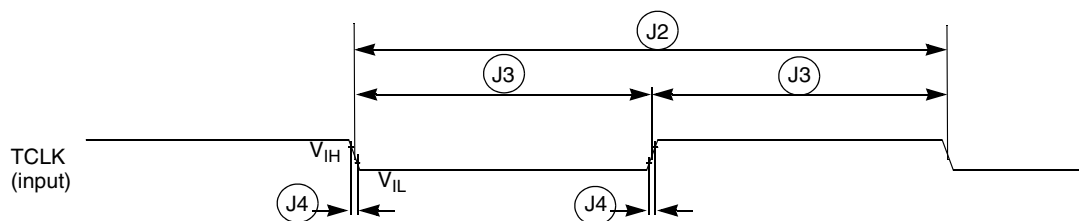


Figure 14. Test Clock Input Timing

2.14 Debug AC Timing Specifications

Table 40 lists specifications for the debug AC timing parameters shown in Figure 19.

Table 40. Debug AC Timing Specification

Num	Characteristic	60 MHz		Units
		Min	Max	
D1	PST, DDATA to CLKOUT setup	4	—	ns
D2	CLKOUT to PST, DDATA hold	1.5	—	ns
D3	DSI-to-DSCLK setup	$1 \times t_{CYC}$	—	ns
D4 ¹	DSCLK-to-DSO hold	$4 \times t_{CYC}$	—	ns
D5	DSCLK cycle time	$5 \times t_{CYC}$	—	ns
D6	$\overline{BKPT}$ input data setup time to CLKOUT Rise	4	—	ns
D7	$\overline{BKPT}$ input data hold time to CLKOUT Rise	1.5	—	ns
D8	CLKOUT high to $\overline{BKPT}$ high Z	0.0	10.0	ns

¹ DSCLK and DSI are synchronized internally. D4 is measured from the synchronized DSCLK input relative to the rising edge of CLKOUT.

Figure 18 shows real-time trace timing for the values in Table 40.

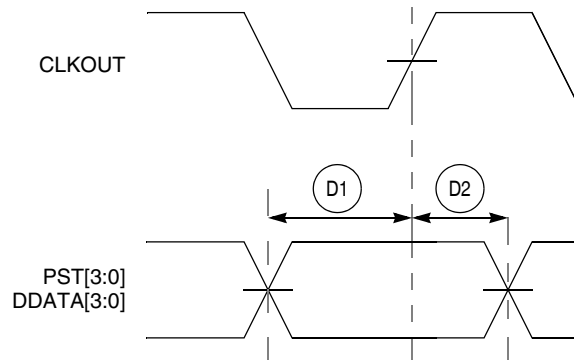


Figure 18. Real-Time Trace AC Timing

Figure 19 shows BDM serial port AC timing for the values in Table 40.

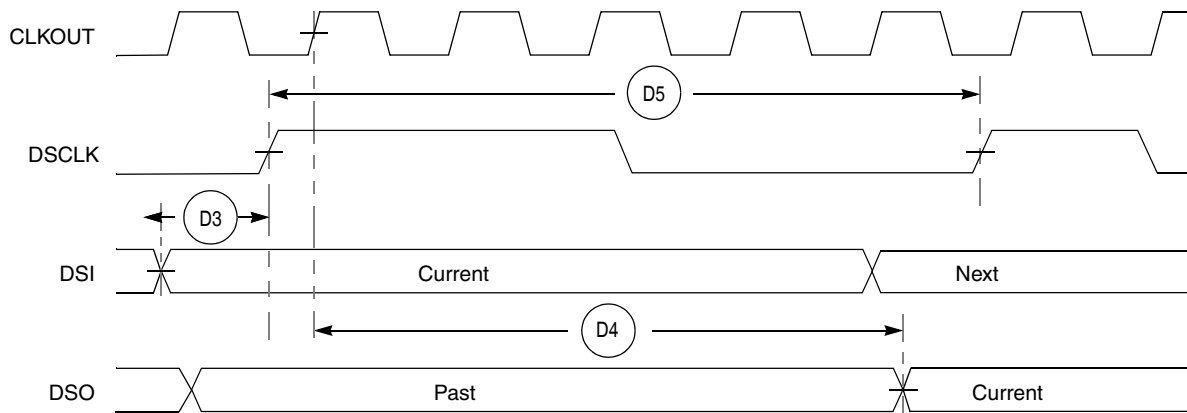
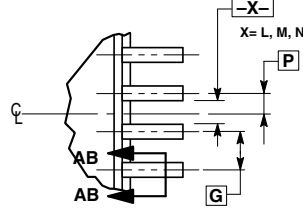
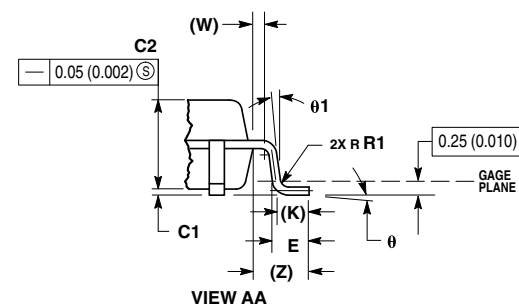
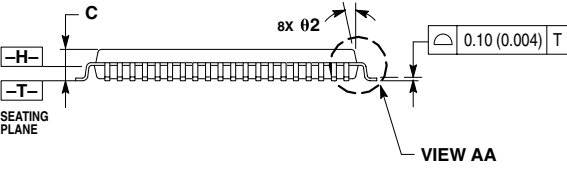
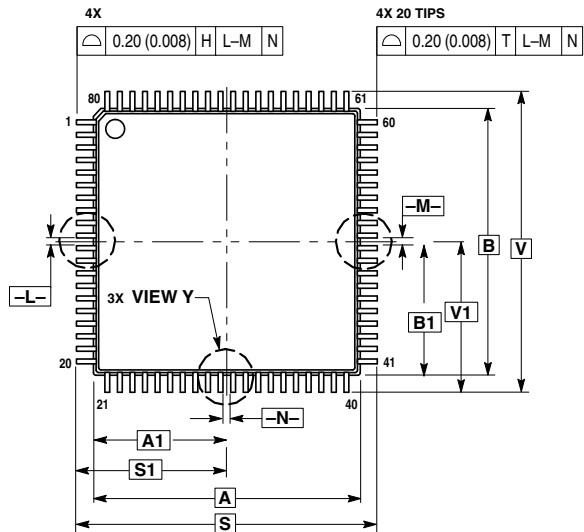


Figure 19. BDM Serial Port AC Timing

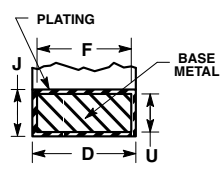
3 Mechanical Outline Drawings

This section describes the physical properties of the MCF52235 and its derivatives.

3.1 80-pin LQFP Package



VIEW Y



SECTION AB-AB
ROTATED 90° CLOCKWISE

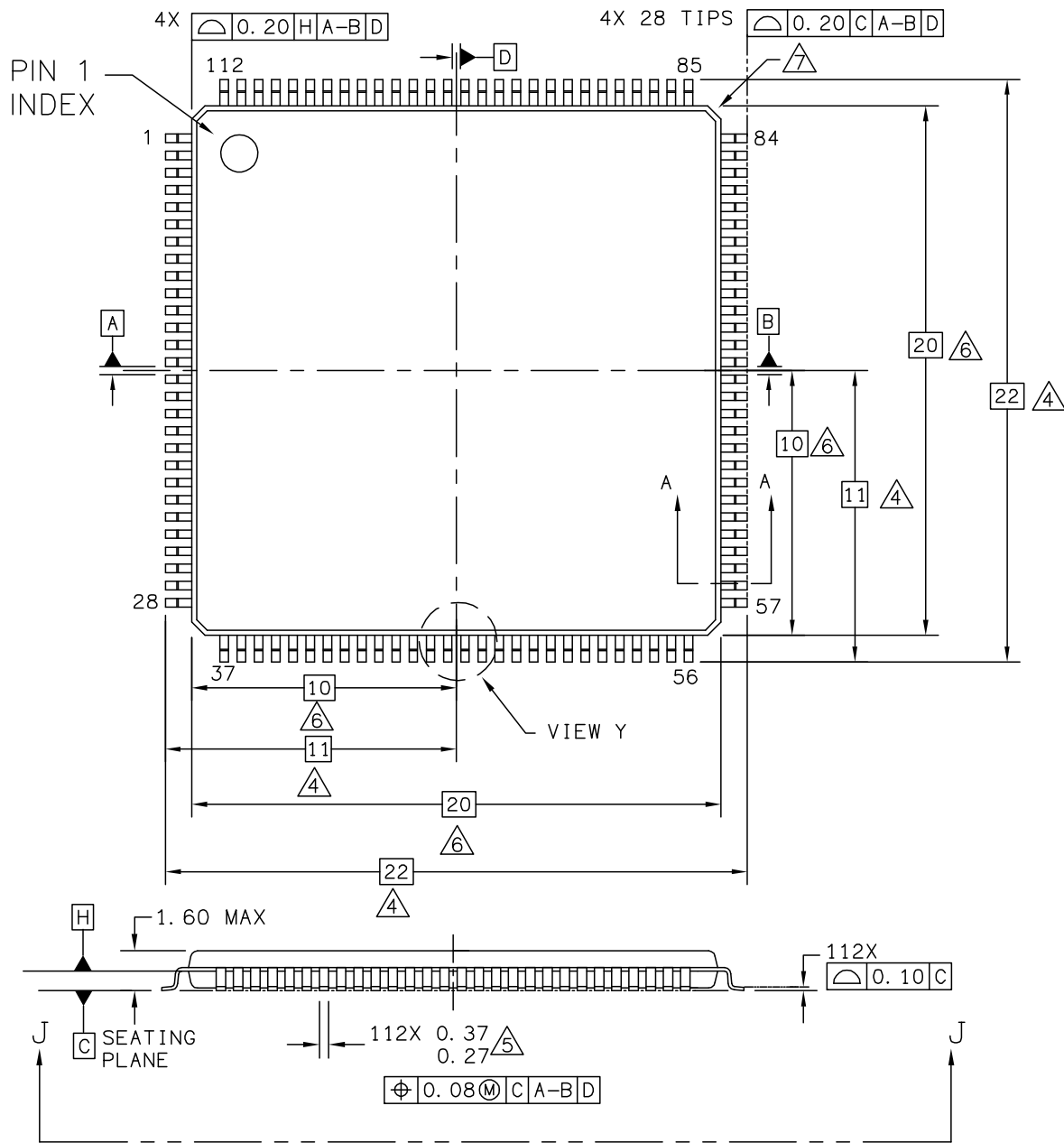
- NOTES:
1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
 2. CONTROLLING DIMENSION: MILLIMETER.
 3. DATUM PLANE -H- IS LOCATED AT BOTTOM OF LEAD AND IS COINCIDENT WITH THE LEAD WHERE THE LEAD EXITS THE PLASTIC BODY AT THE BOTTOM OF THE PARTING LINE.
 4. DATUMS -L-, -M- AND -N- TO BE DETERMINED AT DATUM PLANE -H-.
 5. DIMENSIONS S AND V TO BE DETERMINED AT SEATING PLANE -T-.
 6. DIMENSIONS A AND B DO NOT INCLUDE MOLD PROTRUSION. ALLOWABLE PROTRUSION IS 0.250 (0.010) PER SIDE. DIMENSIONS A AND B DO INCLUDE MOLD MISMATCH AND ARE DETERMINED AT DATUM PLANE -H-.
 7. DIMENSION D DOES NOT INCLUDE DAMBAR PROTRUSION. DAMBAR PROTRUSION SHALL NOT CAUSE THE LEAD WIDTH TO EXCEED 0.460 (0.018). MINIMUM SPACE BETWEEN PROTRUSION AND ADJACENT LEAD OR PROTRUSION 0.07 (0.003).

DIM	MILLIMETERS		INCHES	
	MIN	MAX	MIN	MAX
A	14.00 BSC		0.551 BSC	
A1	7.00 BSC		0.276 BSC	
B	14.00 BSC		0.551 BSC	
B1	7.00 BSC		0.276 BSC	
C	—	1.60	—	0.063
C1	0.04	0.24	0.002	0.009
C2	1.30	1.50	0.051	0.059
D	0.22	0.38	0.009	0.015
E	0.40	0.75	0.016	0.030
F	0.17	0.33	0.007	0.013
G	0.65 BSC		0.026 BSC	
J	0.09	0.27	0.004	0.011
K	0.50 REF		0.020 REF	
P	0.325 BSC		0.013 REF	
R1	0.10	0.20	0.004	0.008
S	16.00 BSC		0.630 BSC	
S1	8.00 BSC		0.315 BSC	
U	0.09	0.16	0.004	0.006
V	16.00 BSC		0.630 BSC	
V1	8.00 BSC		0.315 BSC	
W	0.20 REF		0.008 REF	
Z	1.00 REF		0.039 REF	
Ø	0°	10°	0°	10°
Ø1	0°	—	0°	—
Ø2	9°	14°	9°	14°

CASE 917A-02
ISSUE C

DATE 09/21/95

3.2 112-pin LQFP Package



© FREESCALE SEMICONDUCTOR, INC. ALL RIGHTS RESERVED.		MECHANICAL OUTLINE	PRINT VERSION NOT TO SCALE	
TITLE: 112LD LQFP 20 X 20 X 1.4 0.65 PITCH		DOCUMENT NO: 98ASS23330W		REV: E
		CASE NUMBER: 987-02		25 MAY 2005
		STANDARD: JEDEC MS-026 BFA		

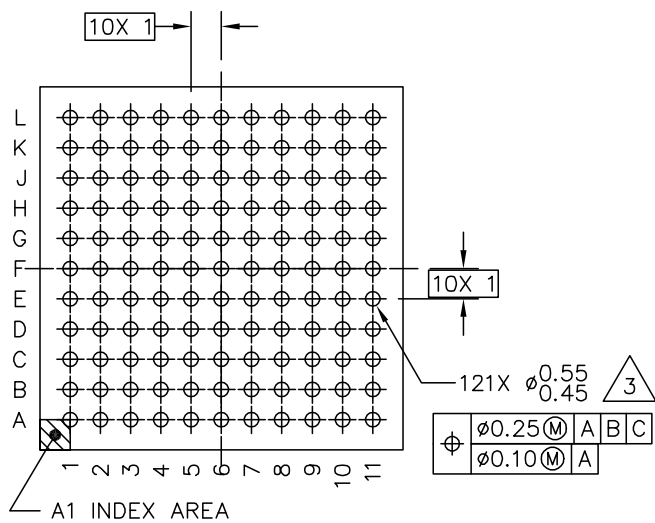
Mechanical Outline Drawings

NOTES:

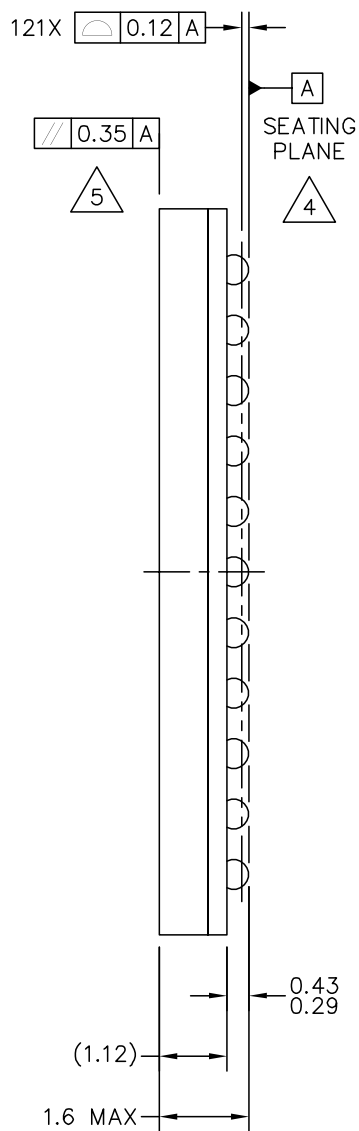
1. DIMENSIONS ARE IN MILLIMETERS.
2. INTERPRET DIMENSIONS AND TOLERANCES PER ASME Y14.5M-1994.
3. DATUMS A, B AND D TO BE DETERMINED AT DATUM PLANE H.
4. DIMENSIONS TO BE DETERMINED AT SEATING PLANE C.
5. THIS DIMENSION DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL NOT CAUSE THE LEAD WIDTH TO EXCEED THE UPPER LIMIT BY MORE THAN 0.08 MM. DAMBAR CANNOT BE LOCATED ON THE LOWER RADIUS OR THE FOOT. MINIMUM SPACE BETWEEN PROTRUSION AND ADJACENT LEAD OR PROTRUSION 0.07 MM.
6. THIS DIMENSION DOES NOT INCLUDE MOLD PROTRUSION. ALLOWABLE PROTRUSION IS 0.254 MM PER SIDE. THIS DIMENSION IS MAXIMUM PLASTIC BODY SIZE DIMENSIONS INCLUDING MOLD MISMATCH.
7. EXACT SHAPE OF EACH CORNER IS OPTIONAL.
8. THESE DIMENSIONS APPLY TO THE FLAT SECTION OF THE LEAD BETWEEN 0.10 MM AND 0.25 MM FROM THE LEAD TIP.

© FREESCALE SEMICONDUCTOR, INC. ALL RIGHTS RESERVED.		MECHANICAL OUTLINE		PRINT VERSION NOT TO SCALE	
TITLE: 112LD LQFP, 20 X 20 X 1.4 PKG, 0.65 PITCH		DOCUMENT NO: 98ASS23330W		REV: E	
		CASE NUMBER: 987-02		25 MAY 2005	
		STANDARD: JEDEC MS-026 BFA			

TOP VIEW



BOTTOM VIEW



SIDE VIEW

© FREESCALE SEMICONDUCTOR, INC. ALL RIGHTS RESERVED.		MECHANICAL OUTLINE		PRINT VERSION NOT TO SCALE	
TITLE: PBGA, LOW PROFILE, 121 I/O, 12 X 12 PKG, 1 MM PITCH (MAP)		DOCUMENT NO: 98ARE10645D		REV: 0	
		CASE NUMBER: 1817-01		15 NOV 2005	
		STANDARD: NON-JEDEC			